

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Denney et al.
Appl. No. : 10/690,833
Filed : October 22, 2003
For : LASER HEAD FOR
IRRADIATION AND REMOVAL
OF MATERIAL FROM A
SURFACE OF A STRUCTURE
Examiner : Maria Alexandra Elve
Group Art Unit : 1725

CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

October 24, 2006

(Date)

Bruce S. Itchkawitz, Reg. No. 47,677

RESPONSE TO JUNE 28, 2006 OFFICE ACTION

Mail Stop Amendment

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In response to the June 28, 2006 Office Action, Applicants respectfully submit the following remarks in connection with the above-captioned application.

Summary of Interview begins on page 2 of this paper.

Remarks/Arguments begin on page 3 of this paper.

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SUMMARY OF INTERVIEW

Attendees, Date and Type of Interview

On October 3, 2006, an interview was conducted telephonically and attended by the Examiner, M. Alexandra Elve, and Applicants' Representatives, Bruce S. Itchkawitz and David A. Petrini.

Exhibits and/or Demonstrations

No exhibits or demonstrations were displayed during the interview.

Identification of Claims Discussed

Claims 1-22 in the current application were discussed.

Identification of Prior Art Discussed

None.

Proposed Amendments

None.

Principal Arguments and Other Matters

Applicants' representatives disputed the Examiner's assertion that the amendment and response of June 15, 2006 introduced subject matter not disclosed in the specification. Applicants' representatives directed the Examiner to particular sections of the specification providing support for the amendments to the claims made on June 15, 2006.

Results of Interview

The Examiner will review the amended claims again in view of the cited paragraphs of the specification and subject the claim language to further searching.